

SN74LV8T164-EP Enhanced Product, 8-Bit Parallel-Out Serial Shift Registers

1 Features

- Wide operating range of 1.65V to 5.5V
- 5.5V tolerant input pins
- Single-supply voltage translator (refer to *LVxT Enhanced Input Voltage*):
 - Up translation:
 - 1.2V to 1.8V
 - 1.5V to 2.5V
 - 1.8V to 3.3V
 - 3.3V to 5.0V
 - Down translation:
 - 5.0V, 3.3V, 2.5V to 1.8V
 - 5.0V, 3.3V to 2.5V
 - 5.0V to 3.3V
- Up to 150Mbps with 5V or 3.3V V_{CC}
- Supports standard function pinout
- Latch-up performance exceeds 250mA per JESD 17
- Supports defense and aerospace applications:
 - Controlled baseline
 - One assembly and test site
 - One fabrication site
 - Extended product life cycle
 - Product traceability

2 Applications

- [Enable or disable a digital signal](#)
- [Controlling an indicator LED](#)
- [Translation between communication modules and system controllers](#)

3 Description

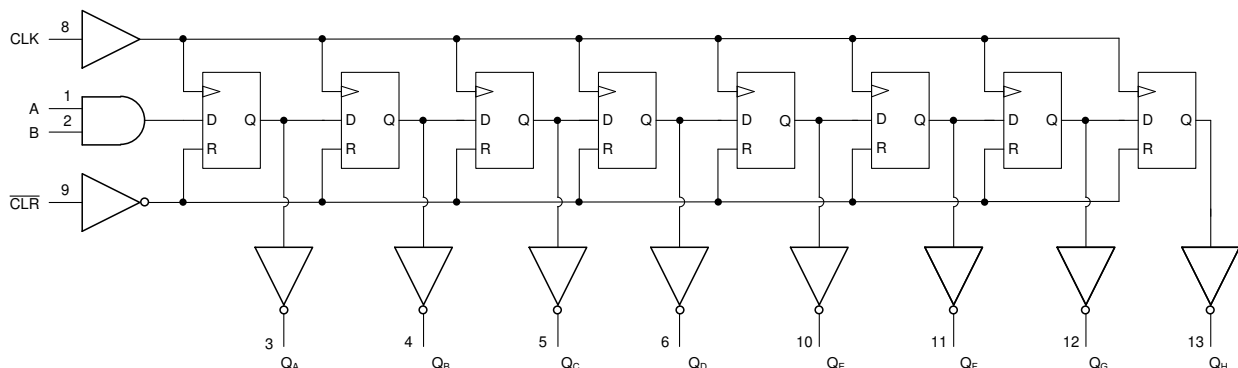
The SN74LV8T164-EP device contains an 8-bit shift register with AND-gated serial inputs and an asynchronous clear (\overline{CLR}) input. The gated serial (A and B) inputs permit complete control over incoming data; a low at either input inhibits entry of the new data and resets the first flip-flop to the low level at the next clock (CLK) pulse. A high-level input enables the other input, which then determines the state of the first flip-flop. Data at the serial inputs is changeable while CLK is high or low, provided the minimum set-up time requirements are met. Clocking occurs on the low-to-high-level transition of CLK.

The input is designed with a reduced threshold circuit to support up translation when the supply voltage is larger than the input voltage. Additionally, the 5V tolerant input pins enable down translation when the input voltage is larger than the supply voltage. The output level is always referenced to the supply voltage (V_{CC}) and supports 1.8V, 2.5V, 3.3V, and 5V CMOS levels.

Package Information

PART NUMBER	PACKAGE ⁽¹⁾	PACKAGE SIZE ⁽²⁾	BODY SIZE ⁽³⁾
SN74LV8T164-EP	PW (TSSOP, 14)	5.0mm × 6.4mm	5mm × 4.4mm

- (1) For more information, see the *Mechanical, Packaging, and Orderable Information* section.
- (2) The package size (length × width) is a nominal value and includes pins, where applicable.
- (3) The body size (length × width) is a nominal value and does not include pins.



Logic Diagram (Positive Logic)



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4 Pin Configuration and Functions

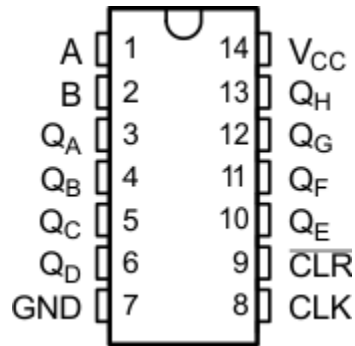


Figure 4-1. PW Package 14-PIN TSSOP (Top View)

Table 4-1. Pin Functions

PIN		TYPE ⁽¹⁾	DESCRIPTION
NO.	NAME		
1	A	I	Serial input A
2	B	I	Serial input B
3	Q _A	O	Output A
4	Q _B	O	Output B
5	Q _C	O	Output C
6	Q _D	O	Output D
7	GND	—	Ground pin
8	CLK	I	Storage clock
9	$\overline{\text{CLR}}$	I	Storage clear
10	Q _E	O	Output E
11	Q _F	O	Output F
12	Q _G	O	Output G
13	Q _H	O	Output H
14	V _{CC}	—	Power pin
-	PAD	—	Thermal Pad ⁽²⁾

(1) I = input, O = output

(2) RGY and BQA packages only

5 Specifications

5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

			MIN	MAX	UNIT
V_{CC}	Supply voltage range		-0.5	7	V
V_I	Input voltage range ⁽²⁾		-0.5	7	V
V_O	Voltage range applied to any output in the high-impedance or power-off state ⁽²⁾		-0.5	7	V
V_O	Output voltage range ⁽²⁾		-0.5	$V_{CC} + 0.5$	V
I_{IK}	Input clamp current	$V_I < -0.5V$		-20	mA
I_{OK}	Output clamp current	$V_O < -0.5V$ or $V_O > V_{CC} + 0.5V$		± 20	mA
I_O	Continuous output current	$V_O = 0$ to V_{CC}		± 25	mA
	Continuous output current through V_{CC} or GND			± 50	mA
T_{stg}	Storage temperature		-65	150	°C

- (1) Operation outside the *Absolute Maximum Ratings* may cause permanent device damage. Absolute maximum ratings do not imply functional operation of the device at these or any other conditions beyond those listed under *Recommended Operating Conditions*. If briefly operating outside the *Recommended Operating Conditions* but within the *Absolute Maximum Ratings*, the device may not sustain damage, but it may not be fully functional. Operating the device in this manner may affect device reliability, functionality, performance, and shorten the device lifetime.
- (2) The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

5.2 ESD Ratings

			VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	± 2000	V
		Charged-device model (CDM), per ANSI/ESDA/JEDEC JS-002 ⁽²⁾	± 1000	

- (1) JEDEC document JEP155 states that 500V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250V CDM allows safe manufacturing with a standard ESD control process.

5.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

Specification	Description	Condition	MIN	MAX	UNIT
V_{CC}	Supply voltage		1.8	5.5	V
V_I	Input voltage		0	5.5	V
V_O	Output voltage		0	V_{CC}	V
V_{IH}	High-level input voltage	$V_{CC} = 1.65V$ to $2V$	1.1		V
		$V_{CC} = 2.25V$ to $2.75V$	1.28		
		$V_{CC} = 3V$ to $3.6V$	1.45		
		$V_{CC} = 4.5V$ to $5.5V$	2		
V_{IL}	Low-Level input voltage	$V_{CC} = 1.65V$ to $2V$		0.5	V
		$V_{CC} = 2.25V$ to $2.75V$		0.65	
		$V_{CC} = 3V$ to $3.6V$		0.75	
		$V_{CC} = 4.5V$ to $5.5V$		0.85	

5.3 Recommended Operating Conditions (continued)

over operating free-air temperature range (unless otherwise noted)

Specification	Description	Condition	MIN	MAX	UNIT
I _O	Output current	V _{CC} = 1.6V to 2V		±3	mA
		V _{CC} = 2.25V to 2.75V		±7	
		V _{CC} = 3.3V to 5.0V		±15	
I _O	Output Current	V _{CC} = 4.5V to 5.5V		±25	mA
Δt/Δv	Input transition rise or fall rate	V _{CC} = 1.6V to 5.0V		20	ns/V
T _A	Operating free-air temperature		-55	125	°C

5.4 Thermal Information

PACKAGE	PINS	THERMAL METRIC ⁽¹⁾						UNIT
		R _{θJA}	R _{θJC(top)}	R _{θJB}	Ψ _{JT}	Ψ _{JB}	R _{θJC(bot)}	
PW (TSSOP)	14	123.4	53.9	79.2	5.0	78.3	-	°C/W

(1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application note.

5.5 Electrical Characteristics

over operating free-air temperature range; typical ratings measured at T_A = 25°C (unless otherwise noted).

PARAMETER	TEST CONDITIONS	V _{CC}	MIN	TYP	MAX	UNIT
V _{OH}	I _{OH} = -50μA	1.2V to 5.5V	V _{CC} -0.2			V
	I _{OH} = -1mA	1.2V	0.8			
	I _{OH} = -2mA	1.65V to 2V	1.21	1.7 ⁽¹⁾		
	I _{OH} = -3mA	2.25V to 2.75V	1.93	2.4 ⁽¹⁾		
	I _{OH} = -5.5mA	3V to 3.6V	2.49	3.08 ⁽¹⁾		
	I _{OH} = -8mA	4.5V to 5.5V	3.95	4.65 ⁽¹⁾		
	I _{OH} = -24mA	4.5V to 5.5V	3.15			
V _{OL}	I _{OL} = 50μA	1.2V to 5.5V			0.1	V
	I _{OL} = 1mA	1.2V			0.2	
	I _{OL} = 2mA	1.65V to 2V		0.1 ⁽¹⁾	0.25	
	I _{OL} = 3mA	2.25V to 2.75V		0.1 ⁽¹⁾	0.2	
	I _{OL} = 5.5mA	3V to 3.6V		0.2 ⁽¹⁾	0.25	
	I _{OL} = 8mA	4.5V to 5.5V		0.3 ⁽¹⁾	0.35	
	I _{OL} = 24mA	4.5V to 5.5V			0.75	
I _I	V _I = 0V or V _{CC}	0V to 5.5V		±0.1	±1	μA
I _{CC}	V _I = V _{CC} or GND, I _O = 0	1.8V to 5.5V		2	20	μA
ΔI _{CC}	One input at 0.3V or 3.4V, other inputs at 0 or V _{CC} , I _O = 0	5.5V		1.35	1.5	mA
	One input at 0.3V or 1.1V, other inputs at 0 or V _{CC} , I _O = 0	1.8V			68	μA
C _I	V _I = V _{CC} or GND	5V		3	5	pF
C _O	V _O = V _{CC} or GND	5V		5	8	pF
C _{PD} ^{(2) (3)}	C _L = 50pF, F = 10MHz	1.8V to 5.5V			200	pF

(1) Typical value at nearest nominal voltage (1.8V, 2.5V, 3.3V, and 5V)

(2) C_{PD} is used to determine the dynamic power consumption, per channel.

(3) $P_D = V_{CC} \times F_I \times (C_{PD} + C_L)$ where F_I = input frequency, C_L = output load capacitance, V_{CC} = supply voltage.

5.6 Switching Characteristics

over operating free-air temperature range; typical values measured at $T_A = 25^\circ\text{C}$ (unless otherwise noted)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	Load Capacitance	V_{CC}	-55°C to 125°C			UNIT
					MIN	TYP	MAX	
T_{PLH}	CLK	Q	CL = 15pF	1.8V		25.3	30.0	ns
T_{PHL}	CLK	Q	CL = 15pF	1.8V		30	35.0	ns
T_{PHL}	CLR	Q	CL = 15pF	1.8V		35.4	42.0	ns
T_{PLH}	CLK	Q	$C_L = 50\text{pF}$	1.8V		28.8	33.5	ns
T_{PHL}	CLK	Q	$C_L = 50\text{pF}$	1.8V		34.6	40.0	ns
T_{PHL}	CLR	Q	$C_L = 50\text{pF}$	1.8V		40.1	46.5	ns
T_{PLH}	CLK	Q	CL = 15pF	2.5V		13.6	16.5	ns
T_{PHL}	CLK	Q	CL = 15pF	2.5V		15.8	19.5	ns
T_{PHL}	CLR	Q	CL = 15pF	2.5V		19.3	24.0	ns
T_{PLH}	CLK	Q	$C_L = 50\text{pF}$	2.5V		15.8	19.5	ns
T_{PHL}	CLK	Q	$C_L = 50\text{pF}$	2.5V		18.9	23.0	ns
T_{PHL}	CLR	Q	$C_L = 50\text{pF}$	2.5V		22.6	28.0	ns
T_{PLH}	CLK	Q	CL = 15pF	3.3V		9.51	17.5	ns
T_{PHL}	CLK	Q	CL = 15pF	3.3V		11	17.5	ns
T_{PHL}	CLR	Q	CL = 15pF	3.3V		13.7	19.5	ns
T_{PLH}	CLK	Q	$C_L = 50\text{pF}$	3.3V		11.3	17.5	ns
T_{PHL}	CLK	Q	$C_L = 50\text{pF}$	3.3V		13.5	17.5	ns
T_{PHL}	CLR	Q	$C_L = 50\text{pF}$	3.3V		16.2	20.0	ns
T_{PLH}	CLK	Q	CL = 15pF	5V		6.89	12.5	ns
T_{PHL}	CLK	Q	CL = 15pF	5V		7.68	12.5	ns
T_{PHL}	CLR	Q	CL = 15pF	5V		9.18	13.9	ns
T_{PLH}	CLK	Q	$C_L = 50\text{pF}$	5V		8.3	12.5	ns
T_{PHL}	CLK	Q	$C_L = 50\text{pF}$	5V		9.55	12.5	ns
T_{PHL}	CLR	Q	$C_L = 50\text{pF}$	5V		11.2	13.9	ns

5.7 Timing Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	DESCRIPTION	CONDITION	V_{CC}	$T_A = 25^\circ\text{C}$		-55°C to 125°C		UNIT
				MIN	MAX	MIN	MAX	
f_{CLOCK}	Clock frequency		1.8V		25.5		22.5	MHz
t_W	Pulse duration	CLR low	1.8V		12		12.5	ns
t_W	Pulse duration	CLK high or low	1.8V		12.5		14.5	ns
t_{SU}	Setup time	Data before CLK \uparrow	1.8V		10		12.5	ns
t_{SU}	Setup time	CLR inactive	1.8V		7.5		9.5	ns
t_H	Hold time	Data after CLK \uparrow	1.8V		1		1	ns
f_{CLOCK}	Clock frequency		2.5V		49		40	MHz
t_W	Pulse duration	CLR low	2.5V		9		10	ns
t_W	Pulse duration	CLK high or low	2.5V		9		10	ns
t_{SU}	Setup time	Data before CLK \uparrow	2.5V		8		9.5	ns
t_{SU}	Setup time	CLR inactive	2.5V		5.5		6.5	ns
t_H	Hold time	Data after CLK \uparrow	2.5V		1		1	ns

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	DESCRIPTION	CONDITION	V _{CC}	T _A = 25°C		-55°C to 125°C		UNIT
				MIN	MAX	MIN	MAX	
f _{CLK}	Clock frequency		3.3V		59		55	MHz
t _W	Pulse duration	CLR low	3.3V	8.5		9		ns
t _W	Pulse duration	CLK high or low	3.3V	8.5		9		ns
t _{SU}	Setup time	Data before CLK↑	3.3V	7.5		8		ns
t _{SU}	Setup time	CLR inactive	3.3V	5		5.5		ns
t _H	Hold time	Data after CLK↑	3.3V	1		1		ns
f _{CLK}	Clock frequency		5V		75	75	62.5	MHz
t _W	Pulse duration	CLR low	5V	8.5		8.5		ns
t _W	Pulse duration	CLK high or low	5V	8		8.5		ns
t _{SU}	Setup time	Data before CLK↑	5V	6		6.5		ns
t _{SU}	Setup time	CLR inactive	5V	4.5		5		ns
t _H	Hold time	Data after CLK↑	5V	1		1		ns

5.8 Typical Characteristics

T_A = 25°C (unless otherwise noted)

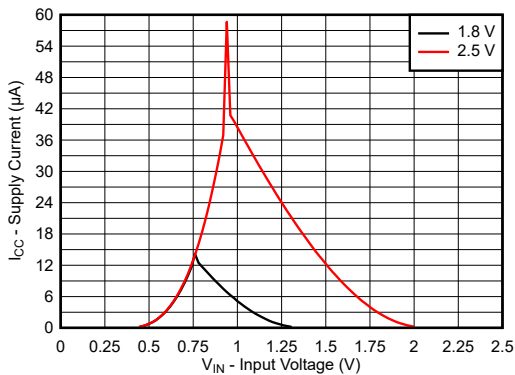


Figure 5-1. Supply Current Across Input Voltage 1.8V and 2.5V Supply

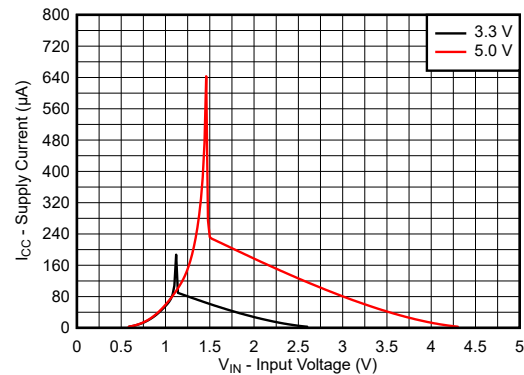


Figure 5-2. Supply Current Across Input Voltage 3.3V and 5.0V Supply

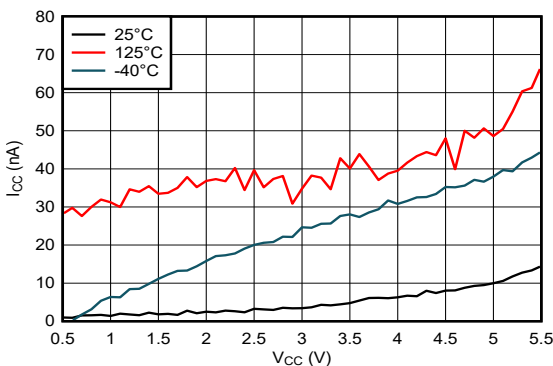


Figure 5-3. Supply Current Across Supply Voltage

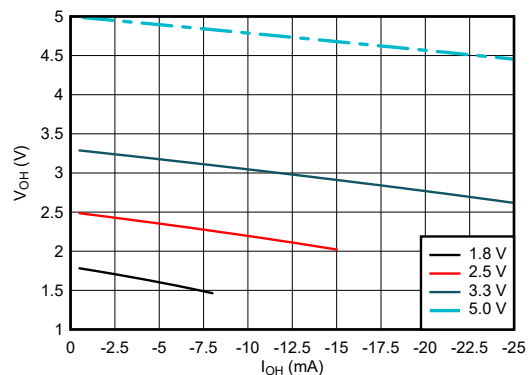


Figure 5-4. Output Voltage vs Current in HIGH State

5.8 Typical Characteristics (continued)

T_A = 25°C (unless otherwise noted)

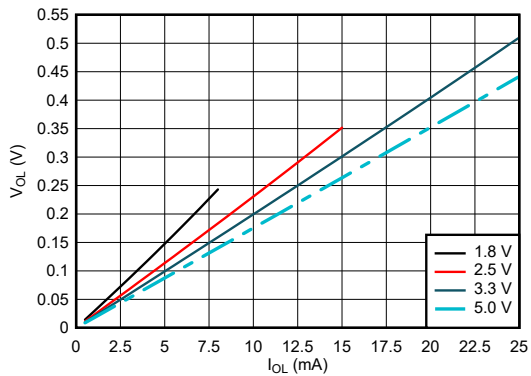


Figure 5-5. Output Voltage vs Current in LOW State

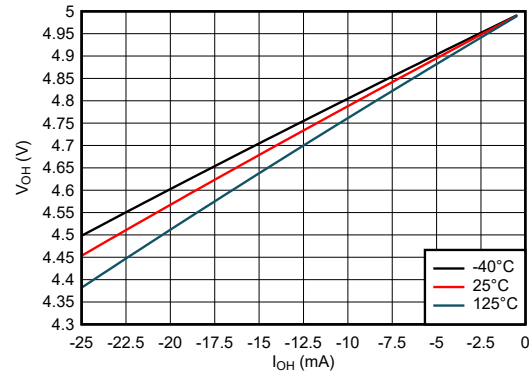


Figure 5-6. Output Voltage vs Current in HIGH State; 5V Supply

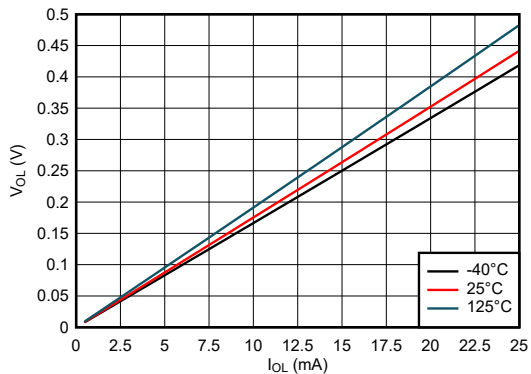


Figure 5-7. Output Voltage vs Current in LOW State; 5V Supply

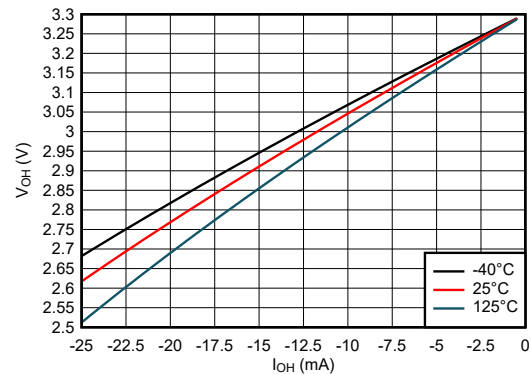


Figure 5-8. Output Voltage vs Current in HIGH State; 3.3V Supply

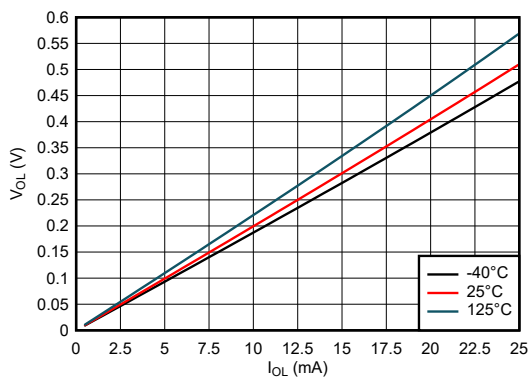


Figure 5-9. Output Voltage vs Current in LOW State; 3.3V Supply

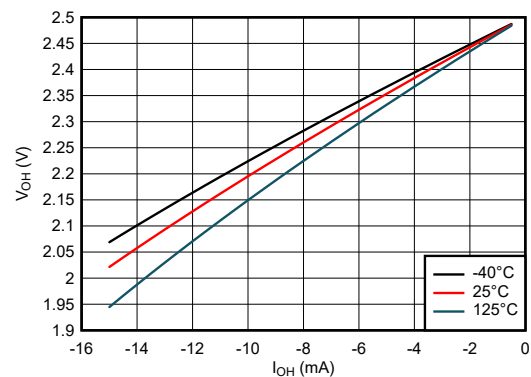


Figure 5-10. Output Voltage vs Current in HIGH State; 2.5V Supply

5.8 Typical Characteristics (continued)

T_A = 25°C (unless otherwise noted)

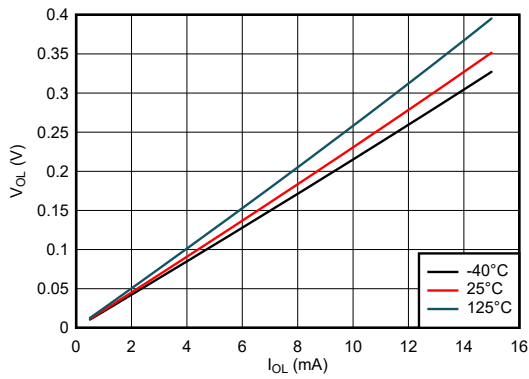


Figure 5-11. Output Voltage vs Current in LOW State; 2.5V Supply

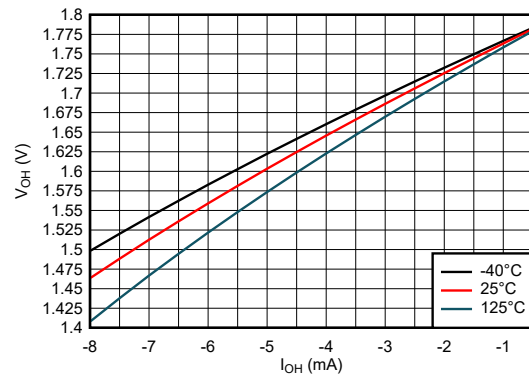


Figure 5-12. Output Voltage vs Current in HIGH State; 1.8V Supply

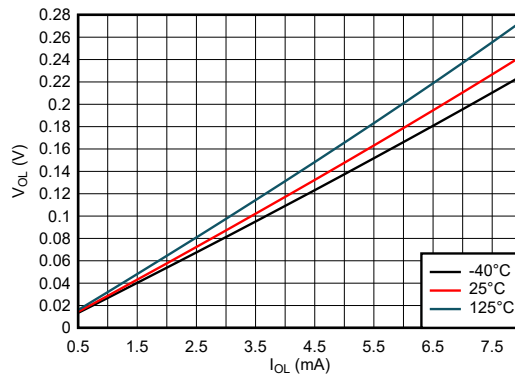


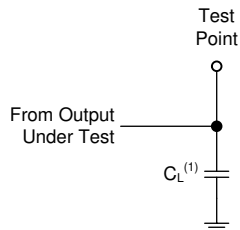
Figure 5-13. Output Voltage vs Current in LOW State; 1.8V Supply

6 Parameter Measurement Information

Phase relationships between waveforms were chosen arbitrarily. All input pulses are supplied by generators having the following characteristics: PRR ≤ 1MHz, $Z_O = 50\Omega$.

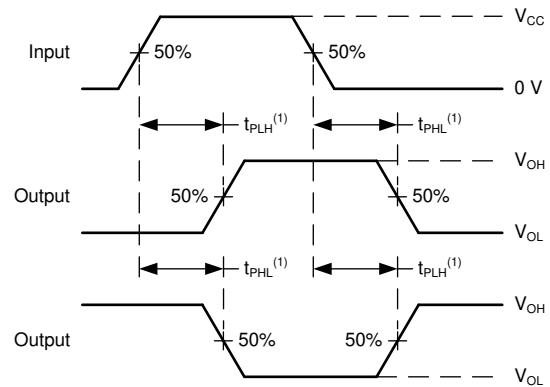
For clock inputs, f_{max} is measured when the input duty cycle is 50%.

The outputs are measured one at a time with one input transition per measurement.



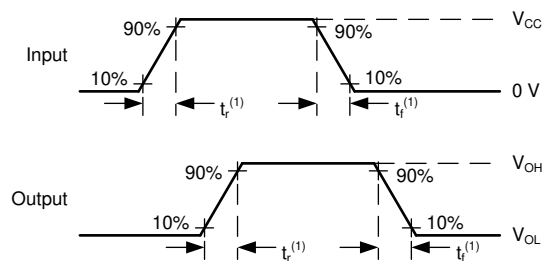
(1) C_L includes probe and test-fixture capacitance.

Figure 6-1. Load Circuit for Push-Pull Outputs



(1) The greater between t_{PLH} and t_{PHL} is the same as t_{pd} .

Figure 6-2. Voltage Waveforms Propagation Delays



(1) The greater between t_r and t_f is the same as t_t .

Figure 6-3. Voltage Waveforms, Input and Output Transition Times

7 Detailed Description

7.1 Overview

The SN74LV8T164-EP is an 8-bit shift register with 2 serial inputs (A and B) connected through an AND gate, as well as an asynchronous clear ($\overline{\text{CLR}}$). The device requires a high signal on both A and B to set the input data line high; a low signal on either input sets the input data line low. Data at A and B can be changed while CLK is high or low, provided that the minimum set-up time requirements are met.

The CLK pin of the SN74LV8T164-EP is rising-edge triggered, activating on the transition from LOW to HIGH. Upon a positive-edge trigger, the device stores the result of the (A • B) input data line in the first register and propagate each register's data to the next register. The data of the last register, Q_H , is discarded at each clock trigger. If a low signal is applied to the $\overline{\text{CLR}}$ pin, then the SN74LV8T164-EP sets all registers to a logical low value immediately.

7.2 Functional Block Diagram

7.3 Feature Description

7.3.1 Balanced CMOS Push-Pull Outputs

This device includes balanced CMOS push-pull outputs. The term *balanced* indicates that the device can sink and source similar currents. The drive capability of this device can create fast edges into light loads, so routing and load conditions must be considered to prevent ringing. Additionally, the outputs of this device are capable of driving larger currents than the device can sustain without being damaged. Limit the output power of the device to avoid damage due to overcurrent. The electrical and thermal limits defined in the *Absolute Maximum Ratings* must be followed at all times.

Unused push-pull CMOS outputs must be left disconnected.

7.3.2 LVxT Enhanced Input Voltage

The SN74LV8T164-EP belongs to TI's LVxT family of logic devices with integrated voltage level translation. This family of devices is designed with reduced input voltage thresholds to support up-translation, and inputs tolerant of signals with up to 5.5V levels to support down-translation. For proper functionality, input signals must remain at or above the specified $V_{IH(MIN)}$ level for a HIGH input state, and at or below the specified $V_{IL(MAX)}$ for a LOW input state. [Figure 7-1](#) shows the typical V_{IH} and V_{IL} levels for the LVxT family of devices, as well as the voltage levels for standard CMOS devices for comparison.

The inputs are high impedance and are typically modeled as a resistor in parallel with the input capacitance given in the *Electrical Characteristics*. The worst-case resistance is calculated with the maximum input voltage, given in the *Absolute Maximum Ratings*, and the maximum input leakage current, given in the *Electrical Characteristics*, using Ohm's law ($R = V \div I$).

Input signals must transition between valid logic states quickly, as the input transition rate in the *Recommended Operating Conditions* table define. Failing to meet this specification results in excessive power consumption and can cause oscillations. More details can be found in the [Implications of Slow or Floating CMOS Inputs](#) application note.

Do not leave inputs floating at any time during operation. Unused inputs must be terminated at a valid high or low voltage level. If a system is not actively driving an input at all times, then a pull-up or pull-down resistor can be added to provide a valid input voltage during these times. The resistor value depends on multiple factors; however, a 10k Ω resistor is recommended and typically meets all requirements.

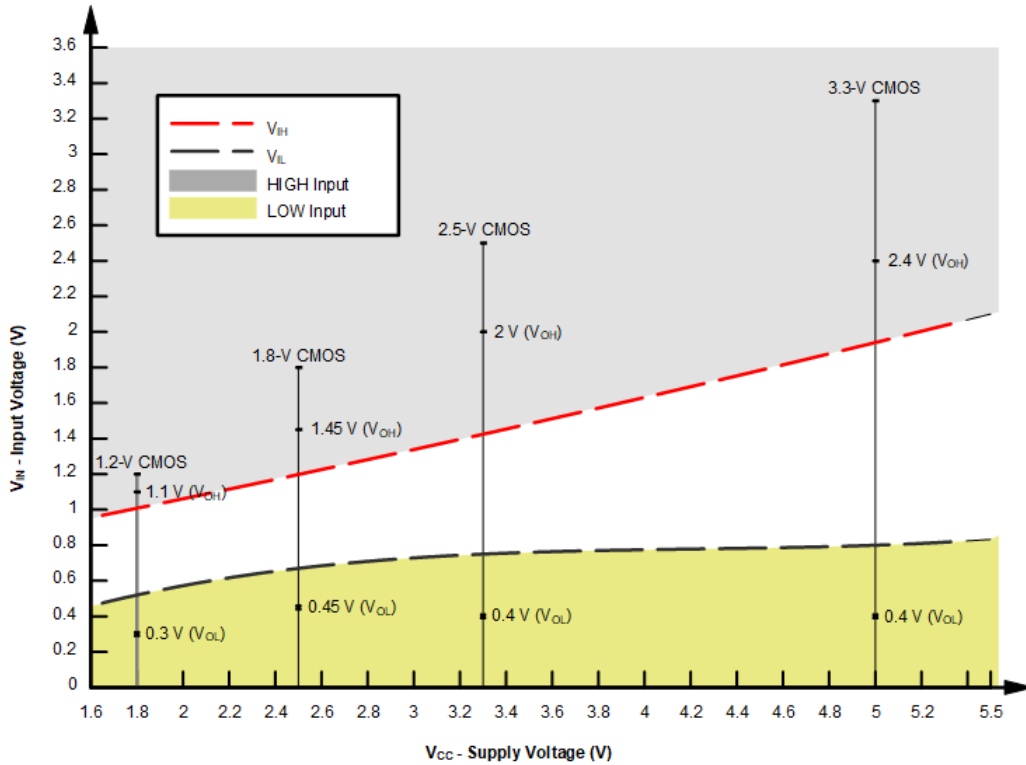


Figure 7-1. LVxT Input Voltage Levels

7.3.2.1 Up Translation

Input signals can be up translated using the SN74LV8T164-EP. The voltage applied at V_{CC} determines the output voltage and the input thresholds as described in the *Recommended Operating Conditions* and *Electrical Characteristics* tables. When connected to a high-impedance input, the output voltage is approximately V_{CC} in the HIGH state, and 0V in the LOW state.

The inputs have reduced thresholds that allow for input HIGH state levels, which are much lower than standard values. For example, standard CMOS inputs for a device operating at a 5V supply has a V_{IH(MIN)} of 3.5V. For the SN74LV8T164-EP, V_{IH(MIN)} with a 5V supply is only 2V, which would allow for up-translation from a typical 2.5V to 5V signals.

Verify that the input signals in the HIGH state are above V_{IH(MIN)} and input signals in the LOW state are lower than V_{IL(MAX)} as shown in Figure 7-2.

Up Translation Combinations are as follows:

- 1.8V V_{CC} – Inputs from 1.2V
- 2.5V V_{CC} – Inputs from 1.8V
- 3.3V V_{CC} – Inputs from 1.8V and 2.5V
- 5.0V V_{CC} – Inputs from 2.5V and 3.3V

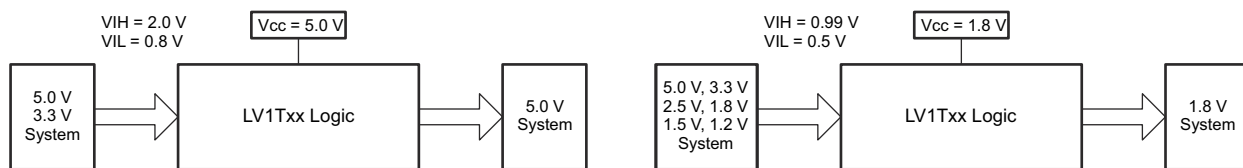


Figure 7-2. LVxT Up and Down Translation Example

7.3.2.2 Down Translation

Signals can be translated down using the SN74LV8T164-EP. The voltage applied at the V_{CC} will determine the output voltage and the input thresholds as described in the *Recommended Operating Conditions* and *Electrical Characteristics* tables.

When connected to a high-impedance input, the output voltage will be approximately V_{CC} in the HIGH state, and 0V in the LOW state. Ensure that the input signals in the HIGH state are between $V_{IH(MIN)}$ and 5.5V, and input signals in the LOW state are lower than $V_{IL(MAX)}$ as shown in Figure 7-1.

For example, standard CMOS inputs for devices operating at 5.0V, 3.3V or 2.5V can be down-translated to match 1.8V CMOS signals when operating from 1.8V V_{CC} . See Figure 7-2.

Down Translation Combinations are as follows:

- 1.8V V_{CC} – Inputs from 2.5V, 3.3V, and 5.0V
- 2.5V V_{CC} – Inputs from 3.3V and 5.0V
- 3.3V V_{CC} – Inputs from 5.0V

7.3.3 Clamp Diode Structure

As Figure 7-3 shows, the outputs to this device have both positive and negative clamping diodes, and the inputs to this device have negative clamping diodes only.

CAUTION

Voltages beyond the values specified in the *Absolute Maximum Ratings* table can cause damage to the device. The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

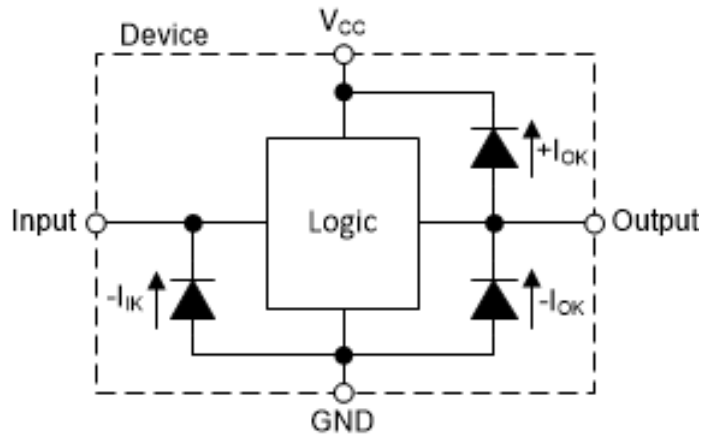


Figure 7-3. Electrical Placement of Clamping Diodes for Each Input and Output

7.4 Device Functional Modes

Table 7-1 lists the functional modes of the SN74LV8T164-EP.

Table 7-1. Function Table

INPUTS ⁽¹⁾				FUNCTION
A	B	CLR	CLK	
X	X	L	X	Shift register is cleared.
L	X	H	↑	First stage of the shift register goes low. Other stages store the data of previous stage, respectively.
X	L	H	↑	First stage of the shift register goes low. Other stages store the data of previous stage, respectively.

Table 7-1. Function Table (continued)

INPUTS ⁽¹⁾				FUNCTION
A	B	$\overline{\text{CLR}}$	CLK	
H	H	H	↑	First stage of the shift register goes high. Other stages store the data of previous stage, respectively.

(1) H = High Voltage Level, L = Low Voltage Level, X = Don't Care

8 Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

8.1 Typical Application

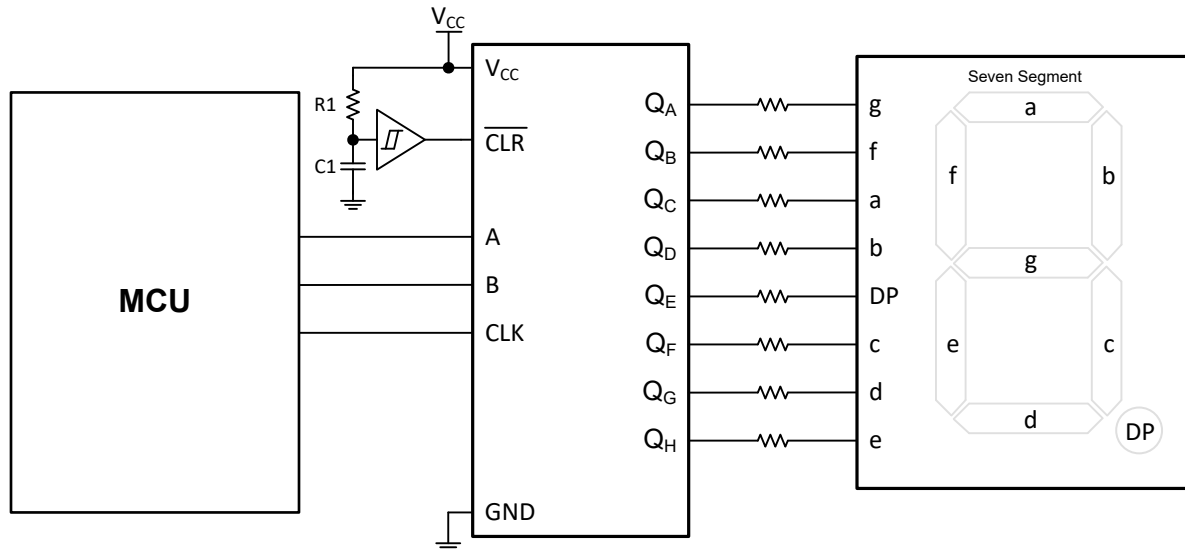


Figure 8-1. Typical Application Block Diagram

8.2 Application Information

In this application, the SN74LV8T164-EP is used to control seven-segment displays. Unlike other I/O expanders, the SN74LV8T164-EP does not need a communication interface for control. It can easily operate with simple GPIO pins. Additional control is provided with two serial inputs that feed into an AND gate.

At power-up, the initial state of the shift registers is unknown. To give them a defined state, the shift register needs to be cleared. An RC can be connected to the $\overline{\text{CLR}}$ pin as shown in *Typical Application Block Diagram* to initialize the shift register to all zeros.

8.2.1 Design Requirements

8.2.1.1 Power Considerations

Verify that the desired supply voltage is within the range specified in the *Electrical Characteristics*. The supply voltage sets the device electrical characteristics, as described in the *Electrical Characteristics* section.

The positive voltage supply must be capable of sourcing current equal to the total current to be sourced by all outputs of the SN74LV8T164-EP plus the maximum static supply current, I_{CC} , listed in the *Electrical Characteristics*, and any transient current required for switching. The logic device can only source as much current that is provided by the positive supply source. Verify that the maximum total current through V_{CC} listed in the *Absolute Maximum Ratings* is not exceeded.

The ground must be capable of sinking current equal to the total current to be sunk by all outputs of the SN74LV8T164-EP plus the maximum supply current, I_{CC} , listed in the *Electrical Characteristics*, and any transient current required for switching. The logic device can only sink as much current that can be sunk into the ground connection. Verify that the maximum total current through GND listed in the *Absolute Maximum Ratings* is not exceeded.

The SN74LV8T164-EP can drive a load with a total capacitance less than or equal to 50pF while still meeting all of the datasheet specifications. Larger capacitive loads can be applied; however, do not exceed 50pF.

The SN74LV8T164-EP can drive a load with total resistance described by $R_L \geq V_O / I_O$, with the output voltage and current defined in the *Electrical Characteristics* table with V_{OH} and V_{OL} . When outputting in the HIGH state, the output voltage in the equation is defined as the difference between the measured output voltage and the supply voltage at the V_{CC} pin.

Total power consumption can be calculated using the information provided in the [CMOS Power Consumption and Cpd Calculation application note](#).

Thermal increase can be calculated using the information provided in the [Thermal Characteristics of Standard Linear and Logic \(SLL\) Packages and Devices application note](#).

CAUTION

The maximum junction temperature, $T_{J(max)}$ listed in the *Absolute Maximum Ratings*, is an additional limitation to prevent damage to the device. Do not violate any values listed in the *Absolute Maximum Ratings*. These limits are provided to prevent damage to the device.

8.2.1.2 Input Considerations

Input signals must cross to be considered a logic LOW, and to be considered a logic HIGH. Do not exceed the maximum input voltage range found in the *Absolute Maximum Ratings*.

Unused inputs must be terminated to either V_{CC} or ground. The unused inputs can be directly terminated if the input is completely unused, or the inputs can be connected with a pullup or pulldown resistor if the input is used sometimes, but not always. A pullup resistor is used for a default state of HIGH, and a pulldown resistor is used for a default state of LOW. The drive current of the controller, leakage current into the SN74LV8T164-EP (as specified in the *Electrical Characteristics*), and the desired input transition rate limits the resistor size. A 10k Ω resistor value is often used due to these factors.

Refer to the *Feature Description* for additional information regarding the inputs for this device.

8.2.1.3 Output Considerations

The positive supply voltage is used to produce the output HIGH voltage. Drawing current from the output decreases the output voltage as specified by the V_{OH} specification in the *Electrical Characteristics*. The ground voltage is used to produce the output LOW voltage. Sinking current into the output increases the output voltage as specified by the V_{OL} specification in the *Electrical Characteristics*.

Push-pull outputs that can be in opposite states, even for a very short time period, must never be connected directly together. This can cause excessive current and damage to the device.

Two channels within the same device with the same input signals can be connected in parallel for additional output drive strength.

Unused outputs can be left floating. Do not connect outputs directly to V_{CC} or ground.

Refer to the *Feature Description* section for additional information regarding the outputs for this device.

8.2.2 Detailed Design Procedure

1. Add a decoupling capacitor from V_{CC} to GND. The capacitor needs to be placed physically close to the device and electrically close to both the V_{CC} and GND pins. An example layout is shown in the *Layout* section.
2. Verify that the capacitive load at the output is ≤ 50 pF. Low load capacitance can be accomplished by providing short, appropriately sized traces from the SN74LV8T164-EP to the receiving device.
3. Verify that the resistive load at the output is larger than $(V_{CC} / I_{O(max)})\Omega$. Never violate the maximum output current from the *Absolute Maximum Ratings*. Most CMOS inputs have a resistive load measured in M Ω ; much larger than the minimum calculated previously.

4. Thermal issues are rarely a concern for logic gates; however, the power consumption and thermal increase can be calculated using the steps provided in the [CMOS Power Consumption and Cpd Calculation application note](#).

8.2.3 Application Curves

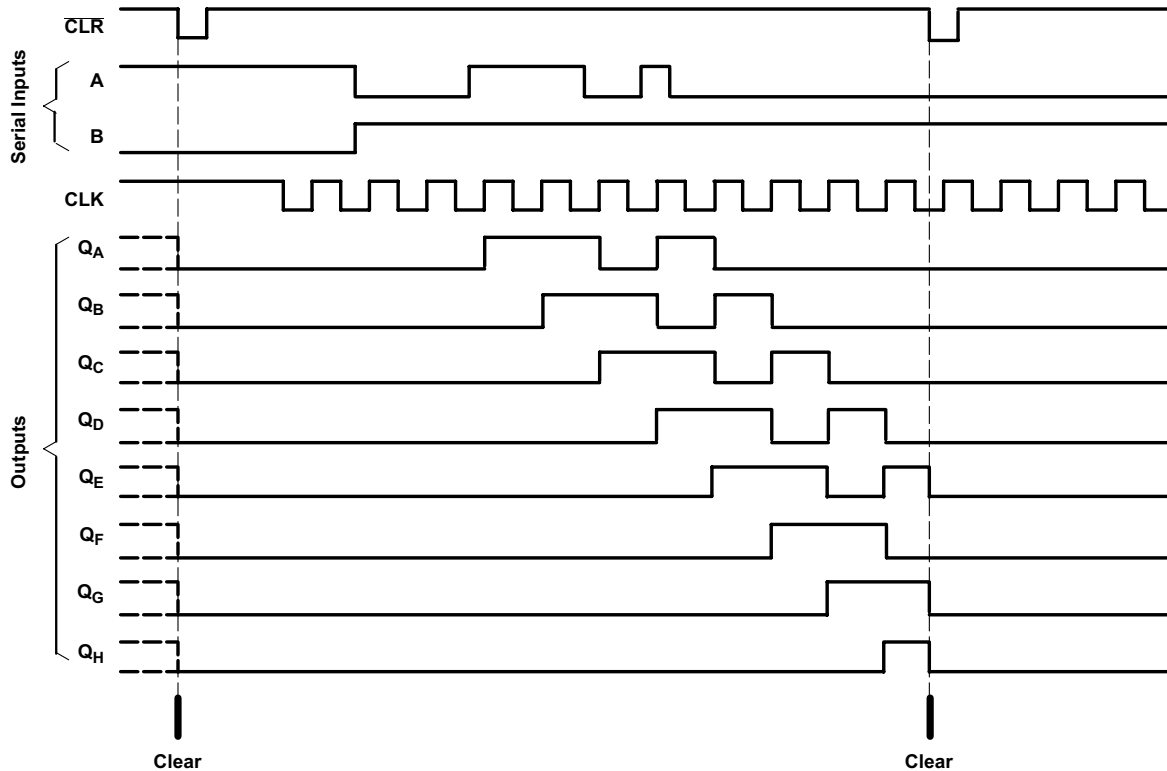


Figure 8-2. Application Timing Diagram

8.3 Power Supply Recommendations

The power supply can be any voltage between the minimum and maximum supply voltage rating located in the *Recommended Operating Conditions*. Each V_{CC} terminal must have a good bypass capacitor to prevent power disturbance.

A 0.1 μ F capacitor is recommended for this device. It is acceptable to parallel multiple bypass capacitors to reject different frequencies of noise. The 0.1 μ F and 1 μ F capacitors are commonly used in parallel. The bypass capacitor must be installed as close to the power terminal as possible for best results.

8.4 Layout

8.4.1 Layout Guidelines

- Bypass capacitor placement
 - Place near the positive supply terminal of the device
 - Provide an electrically short ground return path
 - Use wide traces to minimize impedance
 - Keep the device, capacitors, and traces on the same side of the board whenever possible
- Signal trace geometry
 - 8mil to 12mil trace width
 - Lengths less than 12cm to minimize transmission line effects
 - Avoid 90° corners for signal traces
 - Use an unbroken ground plane below signal traces
 - Flood fill areas around signal traces with ground

- Parallel traces must be separated by at least 3x dielectric thickness
- For traces longer than 12cm
 - Use impedance controlled traces
 - Source-terminate using a series damping resistor near the output
 - Avoid branches; buffer each signal that must branch separately

8.4.2 Layout Example

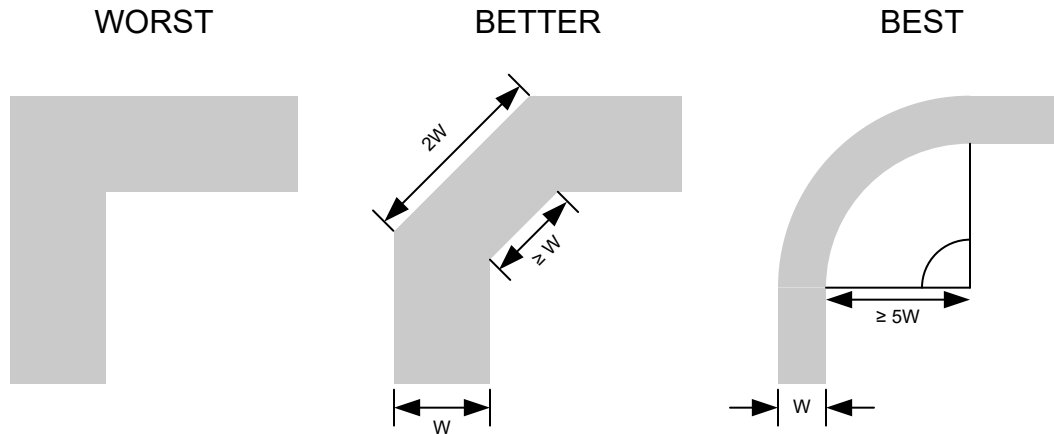


Figure 8-3. Example Trace Corners for Improved Signal Integrity

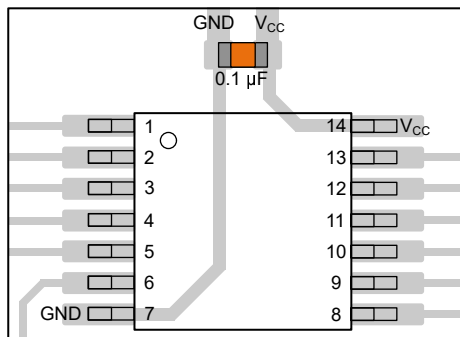


Figure 8-4. Example Bypass Capacitor Placement for TSSOP and Similar Packages

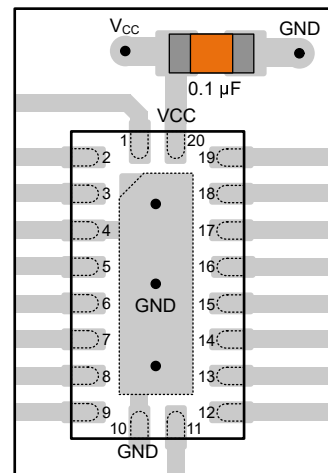


Figure 8-5. Example Bypass Capacitor Placement for WQFN and Similar Packages

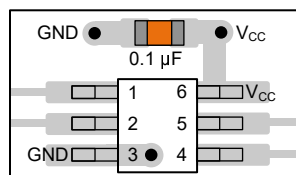


Figure 8-6. Example Bypass Capacitor Placement for SOT, SC70 and Similar Packages

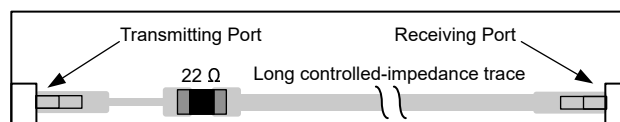


Figure 8-7. Example Damping Resistor Placement for Improved Signal Integrity

9 Device and Documentation Support

TI offers an extensive line of development tools. Tools and software to evaluate the performance of the device, generate code, and develop solutions are listed below.

9.1 Documentation Support

9.1.1 Related Documentation

For related documentation, see the following:

- Texas Instruments, [CMOS Power Consumption and \$C_{pd}\$ Calculation application note](#)
- Texas Instruments, [Designing With Logic application note](#)
- Texas Instruments, [Thermal Characteristics of Standard Linear and Logic \(SLL\) Packages and Devices application note](#)

9.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

9.3 Support Resources

TI E2E™ [support forums](#) are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

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9.4 Trademarks

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9.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

9.6 Glossary

[TI Glossary](#) This glossary lists and explains terms, acronyms, and definitions.

10 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision * (January 2025) to Revision A (May 2026)	Page
• Deleted Q _H 11 pin from pin functions table.....	3

11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
SN74LV8T164MPWREP	Active	Production	TSSOP (PW) 14	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-	LV164EP
SN74LV8T164MPWREP.A	Active	Production	TSSOP (PW) 14	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	See SN74LV8T164MPWREF	LV164EP
V62/25607-01XE	Active	Production	TSSOP (PW) 14	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	See SN74LV8T164MPWREF	LV164EP

(1) **Status:** For more details on status, see our [product life cycle](#).

(2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

(4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "-" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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OTHER QUALIFIED VERSIONS OF SN74LV8T164-EP :

- Catalog : [SN74LV8T164](#)
- Automotive : [SN74LV8T164-Q1](#)

NOTE: Qualified Version Definitions:

- Catalog - TI's standard catalog product
- Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

TAPE AND REEL INFORMATION

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74LV8T164MPWREP	TSSOP	PW	14	3000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1

TAPE AND REEL BOX DIMENSIONS


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74LV8T164MPWREP	TSSOP	PW	14	3000	353.0	353.0	32.0

PW0014A



PACKAGE OUTLINE
TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



4220202/B 12/2023

NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-153.

EXAMPLE BOARD LAYOUT

PW0014A

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 10X



4220202/B 12/2023

NOTES: (continued)

- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

PW0014A

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE: 10X

4220202/B 12/2023

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

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